

**Notice of References Cited**

Application/Control No.

09/924,910

Applicant(s)/Patent Under  
Reexamination  
CHARLTON ET AL.

Examiner

Po-Wei (Dennis) Chen

Art Unit

2676

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,112,015 A	08-2000	Planas et al.	709/223
	B	US-5,581,797 A	12-1996	Baker et al.	345/708
	C	US-5,295,244 A	03-1994	Dev et al.	345/853
	D	US-5,608,854 A	03-1997	Labeledz et al.	345/441
	E	US-5,909,217 A	06-1999	Bereiter, Thomas William	345/854
	F	US-6,054,987 A	04-2000	Richardson, David E.	345/734
	G	US-6,144,379 A	11-2000	Bertram et al.	345/835
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.